

Notice of References Cited	Application/Control No. 10/524,227		Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner LINH T. NGUYEN		Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0025460	02-2005	Hyodo et al.	386/095
*	B	US-6,118,754	09-2000	Sako et al.	369/275.3
	C	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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